Philips Components-Signetics

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Document No.	853-0130
ECN No.	86487
Date of Issue	November 11, 1986
Status	Product Specification
Memory Produ	ıcts

82S181 / 82S181A 8K-bit TTL bipolar PROM

DESCRIPTION

The 82S181 and 82S181A are field programmable, which means that custom patterns are immediately available by following the Signetics Generic I fusing procedure. The 82S181 and 82S181A are supplied with all outputs at logical Low. Outputs are programmed to a logic High level at any specified address by fusing the Ni-Cr link matrix.

This device includes on-chip decoding and four Chip Enable inputs for ease of memory expansion. It features 3-State outputs for optimization of word expansion in bused organizations.

Ordering information can be found on the following page.

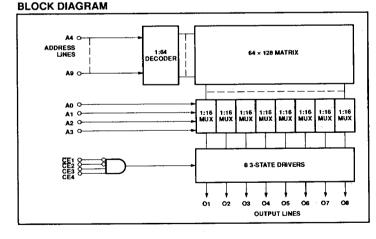
The 82S181 and 82S181A devices are also processed to military requirements for operation over the military temperature range. For specifications and ordering information consult the Signetics Military Data Handbook.

FEATURES

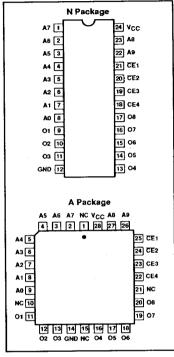
- · Address access time:
 - N82S181: 70ns max
- N82S181A: 55ns max
- Power dissipation: 76μW/bit typ
- Input loading: −100µA max
- On-chip address decoding
- Four Chip Enable inputs
- Outputs: 3-State
- No separate fusing pins
- Unprogrammed outputs are Low level
- Fully TTL compatible

APPLICATIONS

- Prototyping/volume production
- Sequential controllers
- Microprogramming
- · Hardwired algorithms
- Control store
- Random logic
- Code conversion



PIN CONFIGURATIONS



8K-bit TTL bipolar PROM (1024 \times 8)

82S181 / 82S181A

ORDERING INFORMATION

DESCRIPTION	ORDER CODE			
24-Pin Plastic Dual-In-Line 600mil-wide	N82S181 N, N82S181A N			
28-Pin Plastic Leaded Chip Carrier 450mil-square	N82S181 A, N82S181A A			

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT	
Vcc	Supply voltage	+7.0	V _{DC}	
V _{IN}	Input voltage	+5.5	V _{DC}	
Vo	Output voltage Off-State	+5.5	V _{DC}	
T _{amb}	Operating temperature range	0 to +75	°C	
T _{stq}	Storage temperature range	-65 to +150	°C	

DC ELECTRICAL CHARACTERISTICS

 $0^{\circ}C \le T_{amb} \le +75^{\circ}C, 4.75V \le V_{CC} \le 5.25V$

				LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS ^{1,2}	Min	Alin Typ ³		UNIT
Input volt	age ²					
V _{IL}	Low				0.8	٧
ViH	High		2.0			٧
V_{iC}	Clamp	I _{IN} = -12mA		-0.8	-1.2	V
Output vo	Itage ²					
		CE1,2 = Low, CE3,4 = High		I		
VOL	Low	I _{OUT} = 9.6mA			0.45	V
V_{OH}	High	$I_{OUT} = -2.0 \text{mA}$	2.4	İ		٧
Input curi	ent ¹					
I _{IL}	Low	V _{IN} = 0.45V			-100	μА
l _{IH}	High	V _{IN} = 5.5V		Ì	40	μA
Output cu	rrent ¹					
loz	Hi-Z state	CE1,2 = High, CE3,4 = Low, V _{OUT} = 5.5V			40	μΑ
		: CE1,2 = High, CE3,4 = Low, V _{OUT} = 0.5V			-40	μΑ
los	Short circuit ⁴	CE1,2 = Low, CE3,4 = High, V _{OUT} = 0V High stored	-15		-70	mA
Supply cu	ırrent ⁵					
lcc		V _{CC} = 5.25V		125	175	mA
Capacitar	nce		•			
		CE1,2 = High, V _{CC} = 5.0V				
CIN	Input	$V_{1N} = 2.0V$		5		pF
Caut	Output	V _{OUT} = 2.0V	İ	8		pF

NOTES:

- 1. Positive current is defined as into the terminal referenced.

- All voltages with respect to network ground.
 Typical values are at V_{CC} = 5V, T_{amb} = +25°C.
 Duration of the short circuit should not exceed 1 second.
- 5. Measured with all inputs grounded and all outputs open.

8K-bit TTL bipolar PROM (1024 \times 8)

82S181 / 82S181A

AC ELECTRICAL CHARACTERISTICS

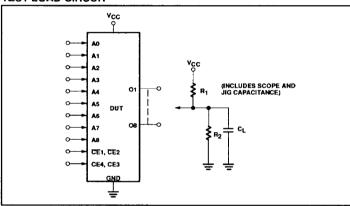
 $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$, $0^{\circ}C \le T_{amb} \le +75^{\circ}C$, $4.75V \le V_{CC} \le 5.25V$

				N82S181		N82S181A				
SYMBOL	PARAMETER	то	FROM	Min	Typ¹	Мах	Min	Typ1	Max	UNIT
Access tir	ne ²									
t _{AA}		Output	Address		50	70		45	55	ns
t _{CE}		Output	Chip Enable		25	40		25	40	ns
Disable tir	ne ³									
t _{CD}		Output	Chip Disable		25	40		25	40	ns

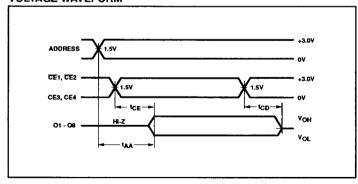
NOTES:

- 1. Typical values are V_{CC} = 5V, T_{amb} = +25°C. 2. Tested at an address cycle time of 1 μ s. 3. Measured at a delta of 0.5V from Logic Level with R_1 = 750 Ω , R_2 = 750 Ω and C_L = 5 ρ F.

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



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